

CURRICULUM VITAE

Prof. DIMITRIS TSOUKALAS

ATHENS, APRIL 2023

Table of Contents

	<i>Page</i>
<i>1. Education</i>	<i>3</i>
<i>2. Professional Activities</i>	<i>3</i>
<i>3. Administrative Responsibilities</i>	<i>4</i>
<i>4. Research Activities</i>	<i>4</i>
<i>5. Development Activities</i>	<i>8</i>
<i>6. Other Scientific Activities</i>	<i>9</i>
<i>7. Educational Activities</i>	<i>11</i>
<i>8. Publications</i>	<i>13</i>

Name: **DIMITRIS TSOUKALAS**

Prof. Address: National Technical University of Athens, Dept. of Appl. Sciences

Date and place of birth: 1956, Athens

1. EDUCATION

1979: Diploma of Electrical and Mechanical Eng., National Technical Un. of Athens.

1980: Diplome DEA (Diplome d' Etudes Approfondies) in Electronics from ENSERG of Institut National Polytechnique de Grenoble (INPG).

1983: Diplome de Docteur-Ingenieur from INPG

In November 1994 I received the '**Habilitation a Diriger des Recherches**' from INPG for my contribution in guiding new researchers towards a PhD in the area of semiconductor process modeling and simulation.

2. PROFESSIONAL ACTIVITIES

2009 - today: Professor at School of Applied Mathematical and Physical Sciences, National Technical University of Athens.

2009-2012: Director Institute of Microelectronics, NCSR Demokritos and Vice President (2011-2012) of NCSR 'Demokritos'.

2002-2009: Assoc. Professor, Director of the postgraduate Diploma on 'Microsystems and Nanodevices', School of Applied Mathematical and Physical Sc., National Technical University of Athens.

1997 – 2002: Research Director (Grade A') at the Inst. of Microelectronics, NCSR 'Demokritos'.

December 1992 - 1997: Principal Researcher (Grade B') at the Inst. of Microelectronics, NCSR 'Demokritos'.

1989: Visiting Scientist at IBM Research Center at Yorktown Heights, USA.

1988 - 1992: Researcher in Charge (Grade C) at the Inst. of Microelectronics, NCSR 'Demokritos'.

1986 - 1988: Researcher in the Dept. of Electronics in the Nuclear Research Center 'Demokritos'. During this period, I participate in transferring MOS technology from the InterUniversity Center in Microelectronics (CIME) of Grenoble to 'Demokritos' through a bilateral cooperation.

1985 - 1986: I have a contract with the Dept. of Electronics of Nuclear Res. Cent. 'Demokritos'. I participate to the design of the clean room facility as well as to the ordering of equipment.

3. ADMINISTRATIVE RESPONSIBILITIES

2021-today: Director of the Dept. of Physics at the School of Applied Math. & Phys. Sciences of NTUA

2017-2021: Member of Management Board NTUA Technology Park

2016-2021: Director of the Laboratory of Advanced Materials and Micro-Nano Devices, Dept. of Physics, NTUA.

2016-18: Coordinating member in ‘Advanced Functional Materials’ Committee, General Secretariat of Research and Technology (GSRT)

2015- : Coordinator of Research and Postgraduate studies Committee at the School of Applied Math. & Phys. Sciences of NTUA.

2011-2012: Vice-President NCSR Demokritos

2009- 2012: Director IMEL, member of Management Board of NCSR Demokritos

2003-2009: Director postgraduate program ‘Microsystems and Nanodevices’ NTUA

2003-2008: Member of Management Board NTUA Technology Park

1998-2002: Deputy Director IMEL, NCSR Demokritos

4. RESEARCH INTERESTS AND ACTIVITIES

My research interests have initially focused on understanding and modeling of front-end silicon processing steps like diffusion, oxidation and implantation and the impact of process physics in predicting MOS device behavior in Silicon and Silicon-On-Insulator materials.

My interests have been later extended to include the use of nanotechnology in silicon processing for the development of new electronic devices focusing more particularly in memories using nanoparticles for charge storage elements formed either by silicon ion implantation in thin oxides and annealing, chemical self-assembly or sputtering. I have also initiated research in MEMS with emphasis in the use of wafer bonding for the development of micromechanical silicon based physical sensors and bio-chemical sensors.

Currently my research focus is on:

- Metal oxide thin films incorporating metallic or metal oxide nanoparticle assemblies with application in memristive devices for future crossbar non-volatile memories and neuromorphic circuits.
- Intelligent surfaces through the realization of physical or bio-chemical nanoparticle-based sensors and sensor arrays on flexible substrates.
- The use of ultrafast processing of semiconductors using laser beams.

I have published more than *180 papers in International journals* in the above areas which have received more than *3450 citations in Web of Science (h-index 31)* and more than *4100 citations (h-index 32) in Scopus*. From my work I hold 3 patents (2 international and 1 national).

- **Participation in research projects**

I was coordinator of 5 European projects (*STIMULATE*, *REGPOT-MiNaSys*, *Marie-Curie-NANOSOURCE*, *IST/FET-FRACTURE*, *ESPRIT-CASE*) and participant in other 7 (*ESPRIT-RAPID*, *IST-FRENDTECH*, *IST-PULLNANO*, *GROWTH-NEON*, *ESPRIT-MICROMEDES*, *HCM - NEWSSTAND*, *HCM-NEXUSTASK*)

I have also participated in 10 projects funded by GSRT or the Ministry of Education in Greece either as coordinator or partner. The above funding has brought more than 5 MEuros to my organizations) during the period 1993-today.

A list of projects is following.

List of Projects

List of International Projects

Title: Nanoparticle sensor arrays on flexible substrates (Lloyds Register Foundation)

Total Budget: 60 kEuros, NTUA budget: 60 kEuros

Start date: 1/10/ 2016, Duration: 36 months

Project Coordinator

Title: Stimulate Public Attitude towards Advanced Materials (STIMULATE, EU)

Total Budget: 1,300 kEuros, NTUA budget: 150 kEuros

Start date: 1/7/ 2013, Duration: 24 months

Project Coordinator

Title: Micro and Nanosystems Center of Excellence (MiNaSys: Regpot, EU)

Total Budget: 2000 kEuros, IMEL/Demokritos budget: 2000 kEuros

Start date: 1/12/ 2009, Duration: 36 months

Project Coordinator

Title: Metallic and semiconducting nanoparticles for source for electronic and optoelectronic applications'

(NANOSOURCE: Marie-Curie, EU)

Total Budget: 1132 kEuros, NTUA budget: 365 kEuros

Start date: 1/8/ 2008, Duration: 48 months

Project partner

Title: Radiation hardness in nanocrystal memories

(European Space Agency)

Total Budget: 150 kEuros, NTUA budget: 100 kEuros

Starting Date: 11/2009, Duration: 24 months

Project Coordinator

Title: Pulling the limits of NanoCMOS

(PULLNANO: Information Society Technologies- EU)

Total Budget: 25000 kEuros, NTUA budget: 150 kEuros

Start Date: 1/6/2006, Duration: 30 months

Project partner

Title: Integrated polymer-based micro fluidic micro system for DNA extraction, amplification, and silicon-based detection

(MICRO2DNA, Information Society Technologies, EU)

Total Budget: 3000 kEuros, NTUA budget: 60 kEuros

Starting Date: 2/2006, Duration: 36 months

Project partner

Title: Front-end technology simulation
(FRIENDTECH, Information Society Technologies, EU)
Total Budget: 2100 kEuros, IMEL/Demokritos budget: 360 kEuros
Starting Date: 7/2001, Duration: 36 months
Project partner

Title: Nanoelectronic devices and Fault-tolerant architectures
(FRACTURE, IST-Future and Emerging Technologies, EU)
Total Budget: 1600 kEuros, IMEL/Demokritos budget: 550 kEuros
Starting Date: 1/ 2001, Duration: 36 months
Project Coordinator

Title: Nanocrystals for Electronic Applications
(NEON, GROWTH-Materials, EU)
Total Budget: 2300 kEuros, IMEL/Demokritos Budget: 450 kEuros
Starting Date: 1/2001, Duration: 36 months
Project partner

Title: Redistribution and Activation Phenomena of dopants during Device Manufacturing
(RAPID, ESPRIT Long Term Research)
Total Budget : 1900 kECUs, IMEL Budget: 360 kECUs
Start date: 1/5/ 1997, Duration: 36 months
Partner

Title: Capacitive Silicon Sensors for Biomedical Applications
(CASE, ESPRIT-COPERNICUS)
Total Budget: 360 kECUs, IMEL Budget : 120 kECUs
Start date: 1/12/ 1996, Duration: 18 months
Project Coordinator

Title: Modular Microsystem for Controlled Medical Drug Release
(MICROMEDES, ESPRIT)
Total Budget: 3000 kECUs, IMEL Budget: 290 kECUs
Start date: 1/10/ 1993, Duration: 42 months

Title: NEXUSTASK (Human Capital & Mobility Network on Silicon Integrated Sensors)
Total Budget: 400 kECUs, IMEL Budget: 22 kECUs
Start date: 1/10/ 1993, Duration: 36 months

Title: NEWSSTAND (Human Capital & Mobility Network on Process and Device Simulation)
Total Budget: 155 kECUs, IMEL Budget: 13 kECUs
Start date: 1/10/1993, Duration: 36 months

List of National projects

Title: A microfluidic chip-based system for the detection of contaminants in water (GSRT)
Total Budget: 850 kEuros, NTUA budget: 205 kEuros
Start date: 1/11/2020, Duration: 30 months
Project participant

Title: RAPID, TIMELY DIAGNOSIS AND MONITORING OF MICROBIAL INFECTIONS BY MEANS OF AN AUTOMATED, POINT-OF-CARE, DIAGNOSTIC SYSTEM (GSRT)

Total Budget: 600 kEuros, NTUA budget: 100 kEuros
Start date: 1/08/2018, Duration: 36 months
Project participant

Title: Electronic Switching Resistance Devices for Neuromorphic Applications.
Total Budget: 50 kEuros, NTUA budget: 50 kEuros
Start date: 1/1/2020, Duration: 15 months
Project coordinator

Title: National Infrastructure in Advanced Materials, Nanotechnology and Nanoelectronics.
Total Budget: 4 MEuros, NTUA budget: 150 kEuros
Start date: 1/2/2018, Duration: 42 months
Project participant

Title: Research project IKY/Siemens
Total Budget: 47 kEuros, NTUA budget: 47 kEuros
Start date: 1/11/2015, Duration: 22 months
Project Coordinator

Title: Nanoparticles Assemblies for Resistive Memories (GSRT: ARISTEIA II)
Total Budget: 300 kEuros, NTUA budget: 250 kEuros
Start date: 18/2/2014/, Duration: 20 months
Project Coordinator

Title: Pesticides Monitoring Systems using Nanosensors for Safe Food Production
Total Budget: 350 kEuros, NTUA budget: 90 kEuros
Start date: 15/4/2012, Duration: 28 months
Scientific Coordinator

Title: Thin Film Silicon Photovoltaics (GSRT: SYNERGASIA)
Total Budget: 760 kEuros, NCSR Demokritos budget: 220 kEuros
Start date: 18/2/2011/, Duration: 36 months
Project Coordinator

Title: Nanoparticle chemical sensors (HERAKLEITOS, MINISTRY OF EDUCATION)
Total Budget: 45 kEuros, NTUA budget: 45 kEuros
Start date: 1/9/2010, Duration: 36 months
PhD fellowship to Mr. E. Skotadis under my supervision

Title: Laser annealing in silicon studied by experiments and simulation (HERAKLEITOS, MINISTRY OF EDUCATION)
Total Budget: 45 kEuros, NTUA budget: 45 kEuros
Start date: 1/6/2011, Duration: 36 months
PhD fellowship to Mr. S. Stathopoulos under my supervision

Title: Fabrication of nanoparticles and their application to charge storage (GSRT: Non-EU cooperation)
Total Budget: 60 kEuros, NTUA budget: 45 kEuros
Start date: 1/11/ 2006, Duration: 18 months
Project Coordinator

Title: Nanoelectronic Memory Devices, (PYTHAGORAS/MINISTRY OF EDUCATION)
Total Budget: 50 kEuros, NTUA budget: 50 kEuros
Start date: 1/8/ 2003, Duration: 36 months

Project Coordinator

Title: Diffusion and activation of dopants in Germanium (PENED/GSRT)

Total Budget: 130 kEuros, NTUA budget: 60 kEuros

Start date: 1/11/2005, Duration: 36 months

Project Coordinator

Title: Micromechanical sensors with application in food industry (PENED/GSRT)

Total Budget: 145 kEuros, NTUA budget: 60 kEuros

Start date: 1/11/2005, Duration: 36 months

Project partner

Title: Nanoparticles with application in low power electron devices and chemical sensors (Bilateral cooperation between Greece and UK)

Total Budget: 15 kEuros, NTUA budget: 15 kEuros

Start date: 1/8/ 2005, Duration: 24 months

Project Coordinator

Title: Nanocrystal memories (Empirikion Foundation)

Total Budget: 44 kEuros, NTUA budget: 44 kEuros

Start date: 1/8/ 2003, Duration: 24 months

Project Coordinator

Title: Silicon micromechanical humidity sensors

(GSRT)

Total budget: 55 M drahas, IMEL Budget: 25 M drh.

Start date: 1/1/ 2000, Duration: 18 months

Title : Silicon micromechanical sensors using surface micromachining

(GSRT)

IMEL Budget : 10 M drh.

Start date: 1/6/ 1996, Duration: 24 months

Title: SOI structures by wafer bonding

(GSRT)

IMEL budget: 2 M drh.

Start date: 1/12/ 1993, Duration: 24 months

5. DEVELOPMENT ACTIVITIES

As a Professor at NTUA (2002- today) I have contributed to the:

- Design of a clean room laboratory equipped with thin film and nanoparticle deposition systems (sputtering and ALD) as well as to the electrical characterization laboratory establishment.
- Material characterization lab operation where a FESEM (equipped with a Raith e-beam lithography), an XRD, an AFM and a mechanical profilometer are supporting various research activities in the Department and NTUA in general.

As a Director of IMEL (2009-12) I have coordinated the submission and the successful execution of the EU funded project REGPOT that gave the opportunity of purchase and installation of an advanced e-beam system from VISTEC, the first in Greece that will be a key tool for future research and development activities. I have

also proposed the renewal of clean room and equipment infrastructure within the framework of a 'Demokritos' proposal to GSRT.

As a Researcher at 'Demokritos' I have contributed to the:

- Design of the clean room facility and MOS technology establishment at IMEL (1985-1990).

- Off-line micromechanical processing laboratory creation.

As a Researcher at 'Demokritos' I have cooperated with an Israeli start-up company in the period 2002-05 in the field of MEMS. Our pressure sensor that made part of the system developed by Remon Medical company, was successfully implanted in humans to monitor blood pressure (Sinaia Hospital NY, 6/2003).

6. SCIENTIFIC COMMITTEES, INVITED TALKS, REVIEWING

- Editorial Board member in the journals: Microelectronic Engineering (Elsevier), Sensors, Micromachines (MDPI), European Physical Journal-Applied Physics
- Chairman ESSDERC/ESSCIRC (*European Solid State Device Research Conference/European Solid State Circuits Research Conference*) Athens 2009, and member of International Program Committee (yearly, 1999- today)
- Chairman of *SISPAD '01* (Simulation of Semiconductor Devices and Processes IEEE Conference), Athens, Sept. 2001 and member of International Steering Committee 98-2004 and Program Committee, 98-2004 and 2016
- Member of Organizing Committee MRS Symposium on '*Materials and Processes for non-volatile memories*'
 - MRS Fall Meeting, Boston 2004
 - MRS Spring Meeting, San Francisco 2007
- Member of International Program Committee Euroensors Conference (1997-2012)
- Member of International Program Committee of Transducers 2013, 2017, 2019, 2023
- Member of International Program Committee Micro and Nano Engineering International Conference (yearly, 2002-today)
- I have given invited talks in International or National Conferences and Workshops (27) and Universities/Research Organizations (7) presented below.

Invited presentations at International Conferences and Workshops

1. CIMTEC Congress, 9th Forum on New Materials, Symposium on Functional Nanomaterials for New Generation Solid State Chemical Sensors 'Nanoparticle networks for label-free biosensing', Perugia Italy, June 25-29, 2022
2. Physics of Advanced Materials, ICPAM-13, 'Resistive Switching Devices for memory and computing applications' Sant Feliu de Guixols, Costa Brava, Spain, September 24-30, 2021
3. 6th International Workshop on Microsystems 'Nanoparticle based sensors' Sindos, Greece, Dec. 2021
4. 64th Vacuum Society Meeting 'Integration of Metallic Nanoparticles in Sensing and Memory Devices for Resistance Modulation and Enhanced Switching', Tampa, Florida, USA 29 Oct-3 Nov. 2017

5. 5th International Conference from Nanoparticles and Nanomaterials to Nanodevices and Nanosystems (*IC4N*) ‘Enhancing the switching properties of metal oxide resistive memories by nanoparticle incorporation’, Porto Heli, Greece, June 2016
6. Workshop on Frontier in Electronics (WOFE) ‘Understanding the formation of conductive filaments in RRAM through the design of experiments and simulations’ San Juan, USA 15-18 Dec. 2015
7. 5th International Conference on Materials and Applications for Sensors and Transducers (IC-MAST) ‘Nanoparticle sensors’ Myconos 8-11 Sept. 2015
8. Intern. Semiconductor Device Research Symposium (ISDRS) ‘Metal and metal oxide nanoparticles for emerging memories’ 11-13 Dec. 2013 Bethesda, USA
9. National Solid State Physics and Materials Sc. Conference ‘Nanoparticle assemblies and their applications’ Athens, Sept. 2013
10. CIMTEC 2012 ‘Inorganic nanoparticles for either charge storage or memristance modulation’ Montecatini Terme, 10-15 June 2012
11. Nano2012, ‘Nanoparticles assemblies as biochemical sensors’, Rhodes 26-31 August 2012
12. Nanotechnology 2011, ‘Nanoparticles for chemical and physical sensing’, Thessaloniki 12-14 July 2011
13. 9th International Symposium on Test and Measurement, ‘Nanoparticle sensors’ Suzhou, China, 4-7 August 2011
14. Univ. of Patras ‘Research activities of IMEL’, June 2010
15. Nanoparticles 2008, ‘Memory effects in insulators incorporating semiconducting or metallic nanoparticles’ Orlando, Florida, USA, May 2008
16. Smart Materials and Micro-Nanosystems, ‘Nanoparticles for charge storage’, Acireale, Sicily, June 2008
17. Gordon Research Conference/ Supramolecules and self-assembly, ‘Charge storage in nanoparticles for memory applications’ Il Ciocco, Italy, May 2007
18. AsiaNano 2006 ‘Electronic Memories based on organic thin films’ Nov. 2006, Busan, Korea (together with M. Petty)
19. First International Workshop on Semiconductor nanocrystals, SEMINANO 2005, ‘Nanocrystals and their applications in nanocrystal memories’ Budapest, August 2005
20. E-MRS Symposium on Materials Science and Device Issues for Future Si-based Technologies, ‘Recent advances in nanocrystal memories’, Strasbourg June 2005
21. Technical Un. Of Dresden ‘Nanocrystals and their application in nonvolatile memories’ October 2005
22. EU Workshop on Research Training in Nanosciences and Nanotechnologies: Current Status and Future Needs, ‘Postgraduate education in Nanotechnology at NTUA’, Brussels, April 2004
23. Hellenic Association of Physics, ‘From microelectronics to nanoelectronics and nanotechnology’ Loutraki, Greece, February 2004
24. Technical Un. Of Warsaw on ‘MEMS capacitive type devices obtained with wafer bonding’, Warsaw, Feb. 2004
25. 5th International Research Workshop on Future Information Processing Technologies organized by EU, SRC(USA), SELETE (Japan), ‘Gold self-assembled nanoparticles for non-volatile memories’, Miyazaki, Japan, 5-7 Nov. 2003
26. NSF-EU Workshop on Nanomaterials and Nanotechnology, ‘Nanoparticle Memories’, Boston, US, December 2002

27. Second International Research Workshop on Future Information Processing Technologies ‘MOS nanocrystal memory’, Vancouver, Canada, August 1999
 28. ST-Microelectronics ‘Activities on Silicon On Insulator at IMEL’ Tours, France , Jan. 1998
 29. ‘20th International Semiconductor Conference (CAS’97)’, ‘The influence of process physics on the short-channel behaviour of MOS devices. The example of the Reverse Short Channel Effect’ Sinaia, Romania, Oct. 1997
 30. Second International Research Workshop on Future Information Processing Technologies ‘Single-Electron Device Fabrication by extending current Silicon Technology’, Sapporo, Japan, August 1997
 31. National Solid State Physics Association ‘The continuing growth of microelectronics as a result of research industry collaboration’, Athens June 1997
 32. Univ. Of Thrace, Dept. EE ‘Silicon as the material for microelectronic and micromechanical devices’, June 1997
 33. Dept. Of Physics, Univ. of Crete ‘Simulation of silicon processing technologies’, Dec. 1997
 34. Max-Planck Institut fuer Mikrostrukturphysik (Prof. U. Goesele) ‘Application of the Wafer Bonding technique for process physics experiments and micromechanical sensors’, Halle, May 1996
- I have been a reviewer for International Journals (*Nature Communications, Advanced Materials, Small, Nanoscale, Nature Scientific. Rep., ACS Mater. & Interf., ACS Langmuir, ACS J. Phys. Chem., J. Appl. Phys., Appl. Phys. Lett., IEEE Trans. Electr. Dev., IEEE Electron Dev. Lett., IEEE Trans. On Nanotechnology, Microelectronic Eng., J. Electrochem. Soc. Solid-St. Electronics, Semiconductor Sc. & Tech., J. Phys. D, Sens. & Actuat. A, Sens.&Act. B, Synthetic Metals, J. Vacuum & Technol. B*).
 - I have been a reviewer for European and national funding organizations as well as prize organizations in Greece (Bodosakis Prize) and Japan (‘Japan Prize’ from Japan Prize Foundation annually from 2006).
 - I was a member of the *Expert Evaluation Committee* of the French Laboratory Institut d' Electronique de Microélectronique et de Nanotechnologie (CNRS-IEMN) in Lille, France (January 2019)

7. EDUCATIONAL ACTIVITIES

- I have established and I was the first Director of postgraduate diploma on ‘Microsystems and Nanodevices’ at NTUA with the participation of 5 Schools from NTUA and IMEL/NCSR Demokritos for the period 2002-2009. Within this diploma I use to teach a course on Micro and Nano sensors and a course on Nanoelectronic Devices.
- I have taught courses on Semiconductor Devices, Microsystems Technology and Electromagnetism for undergraduate students.
- I have supervised a total number of 30 diploma or postgraduate diploma thesis. Under my supervision 16 candidates have obtained their PhD and 4 others are currently preparing it. Namely:

- Ms. Maria Kainourgiaki, Electrical Engineer, ELIDEK fellow
- Mr. Charalampos Tsiouostas, Electrical Engineer, supported by research project
- Mr. Georgios Klitsiotis, Applied Physics, supported by research project
- Mr. Stavros Kitsios, Physicist, IKY fellow
- Dr. Charalampos Papaconstantinopoulos, ELIDEK fellow, recently graduated
- Dr. Leonidas Madianos, own business
- Dr. Panagiotis Bousoulas, post-doctoral researcher at NTUA, recipient of D. Chorafas Foundation Prize 2018
- Dr. Spyros Stathopoulos, Experimental Officer at Micro Nano Syst. Lab, University of Edinburgh, UK
- Dr. Lampros Patsiouras, engineer at ITMA innovation, Athens
- Dr. Panagiotis Tsouroutas, own business
- Dr. Evangelos Skotadis, post-doctoral researcher at NTUA, Lecturer Univ. of West Attica
- Dr. Jun Tang, Professor at North Univ. of China
- Dr. Antonios Florakis, energy consultant for PV to TotalEnergies, S.A, Leuven, Belgium
- D. Emanuele Verrelli, Senior Lecturer, Dept. of Physics, University of Hull, UK
- Dr. Pascal Normand, Dr. Christos Tsamis, Dr. Stavros Chatzandroulis (Researchers Grade A, Inst. of Nanoscience and Nanotechnology, NCSR Demokritos)
- D. Dimitrios Skarlatos, Professor, Dept. of Physics, University of Patras
- Dr. Stavroula Kolliopoulou, Educational Advisor, Ministry of Education
- Dr. Dimitris Goustouridis, Assoc. Professor, Dept. of Electrical and Electronic Engineering, Univ. of West Attica

- I have participated in numerous thesis examination committees in Greek Universities and abroad (Univ. Paul Sabatier Toulouse, ETH Zurich, Institut National Polytechnique de Grenoble, Ecole Polytechnique Paris, Univ. of Cambridge, Technical Un. of Dresden, University College Cork).

8. PUBLICATIONS

International Journal publications

1. G. Klitsiotis, P. Bousoulas, C. Tsiouostas, D. Tsoukalas, ‘Demonstration of artificial afferent nerve properties with forming-free and SiO₂-based memristive synapses’, *IEEE Transactions on Electron Devices*, accepted for publication
2. C Tsiouostas, P Bousoulas, G Kleitsiotis, D Tsoukalas, Pulse-stream impact on recognition accuracy of reservoir computing from SiO₂-based low power memory devices *APL Machine Learning* 1 (2), 026103 (2023)
3. C. Tsiouostas, P. Bousoulas, J. Hadfield, T.P. Chatzinikolaou, I.-A. Fyrigos, V. Ntinis, M.-A. Tsompanas, G. Sirakoulis, D. Tsoukalas ‘Simulation of low power self-selective memristive neural networks for in situ digital and analogue artificial neural network applications’ *IEEE Trans. on Nanotechnology*, 21, 505 (2022)
4. C. Papakonstantinopoulos, P. Bousoulas, E. Aslanidis, E. Skotadis, M. Tsigkourakos, D. Tsoukalas ‘Highly sensitive stretchable sensor combined with low-power memristor for demonstration of artificial mechanoreceptor properties’ *Flexible and Printed Electronics* 7, 035024, (2022)
5. S. Kitsios et al. ‘Demonstration of Enhanced Switching Variability and Conductance Quantization Properties in a SiO₂ Conducting Bridge Resistive Memory with Embedded Two-Dimensional MoS₂ Material’, *ACS Appl. Electron. Mater.*, 4, 6, 2869–2878 (2022)
6. P Bousoulas, C Tsiouostas, J Hadfield, V Aslanidis, S Limberopoulos, D Tsoukalas ‘Low Power Stochastic Neurons From SiO₂-Based Bilayer Conductive Bridge Memristors for Probabilistic Spiking Neural Network Applications—Part I’ *IEEE Transactions on Electron Devices* 69, 2360 (2022)
7. E Skotadis, E Aslanidis, G Kokkoris, EAV Kousoulas, A Tserepi, S. Chatzandroulis, D. Tsoukalas, ‘Flow determination via nanoparticle strain sensors for easy Lab on Chip integration’, *Sensors and Actuators A* 344, 113765 (2022)
8. P. Bousoulas, S. Kitsios, T.P. Chatzinikolaou, I-A. Fyrigos, V. Ntinis, M.-A Tsompanas, G. Sirakoulis, D. Tsoukalas ‘Material design strategies for emulating neuromorphic functionalities with resistive switching memories, *Japanese Journal of Applied Physics* 61 (2022)
9. M Kaloumenou, E Skotadis, N Lagopati, E Efstathopoulos, D Tsoukalas, ‘Breath Analysis: A Promising Tool for Disease Diagnosis—The Role of Sensors’, *Sensors* 22 (3), 1238 (2022)
10. P Bousoulas, C Tsiouostas, D Tsoukalas, ‘Emulating low power nociceptive functionalities with a forming-free SiO₂/VO_x conductive bridge memory with Pt nanoparticles’, *Applied Physics Letters* 120 (25), 253509 (2022)

11. M. Tsigkourakos, M. Kainourgiaki, E. Skotadis, K.P. Giannakopoulos, D. Tsoukalas, Y.S. Raptis ‘Capping technique for chemical vapor deposition of large and uniform MoS₂ flakes’ *Thin Solid Films* (2021) 138808
12. C. Papakonstantinou, P. Bousoulas, M. Tsigkourakos, D. Sakellaropoulos, L. Sygellou, D. Tsoukalas, ‘Highly Flexible Artificial Synapses from SiO₂-Based Conductive Bridge Memristors and Pt Nanoparticles through a Crack Suppression Technique’, *ACS Applied Electronic Materials*, 10.1021/acsaelm.1c00302 (2021)
13. E. Aslanidis, E. Skotadis, D. Tsoukalas, ‘Simulation tool for predicting and optimizing the performance of nanoparticle-based strain sensors’ *Nanotechnology* 32 (27), 275501 (2021)
14. P. Bousoulas, D. Sakellaropoulos, D. Tsoukalas, ‘Tuning the analog synaptic properties of forming free SiO₂ memristors by material engineering’, *Applied Physics Letters* 118 (14), 143502 (2021)
15. P. Bousoulas, M. Panagopoulou, N. Boukos, D. Tsoukalas, ‘Emulating artificial neuron and synaptic properties with SiO₂-based memristive devices by tuning threshold and bipolar switching effects’, *Journal of Physics D: Applied Physics* 54 (22), 225303 (2021)
16. E. Skotadis, A. Kanaris, E. Aslanidis, N. Kalatzis, F. Chatzipapadopoulos, N. Marianos, D. Tsoukalas, ‘Identification of two commercial pesticides by a nanoparticle gas-sensing array’, *Sensors* 21 (17), 5803 (2021)
17. P. Bousoulas, C. Papakonstantinou, S. Kitsios, K. Moustakas, G. Sirakoulis, D. Tsoukalas, ‘Emulating Artificial Synaptic Plasticity Characteristics from SiO₂-Based Conductive Bridge Memories with Pt Nanoparticles’, *Micromachines* 12 (3), 306 (2021)
18. F. Zacharatos, M. Duderstadt, E. Almpanis, L. Patsiouras, K. Kurselis, D. Tsoukalas, C. Reinhardt, N. Papanikolaou, B. N. Chichkov, I. Zergioti ‘Laser printing of Au nanoparticles with sub-micron resolution for the fabrication of monochromatic reflectors on stretchable substrates’, *Optics & Laser Technology* 135, 106660 (2021)
19. D. Sakellaropoulos, P. Bousoulas, C. Papakonstantinou, S. Kitsios, D. Tsoukalas, ‘Impact of Active Electrode on the Synaptic Properties of SiO₂-Based Forming-Free Conductive Bridge Memory’, *IEEE Transactions on Electron Devices* 68 (4), 1598-1603 (2021)
20. E. Aslanidis, E. Skotadis, D. Tsoukalas, ‘Resistive crack-based nanoparticle strain sensors with extreme sensitivity and adjustable gauge factor made on flexible substrates’ *Nanoscale*, 13 (5), 3263-3274 (2021)
21. E. Skotadis, E. Aslanidis, M. Kainourgiaki and D. Tsoukalas ‘Nanoparticles Synthesised in the Gas-Phase and their Applications in Sensors: A Review’, *Appl. Nano*, 1, 70–86; doi:10.3390/aplnano1010006 (2020)

22. E. Skotadis, A. Kanaris, E. Aslanidis, P. Michalis, N. Kalatzis, F. Chatzipapadopoulou, N. Marianos, D. Tsoukalas, 'A sensing approach for automated and real-time pesticide detection in the scope of smart-farming' *Computers and Electronics in Agriculture*, 178, 105759 (2020)
23. P. Bousoulas, D. Sakellaropoulos, C. Papakonstantinopoulos, S. Kitsios, C. Arvanitis, E. Bagakis and D. Tsoukalas, 'Investigating the origins of ultra-short relaxation times of silver filaments in forming-free SiO₂ -based conductive bridge memristors' *Nanotechnology* 31, 454002 (2020)
24. D. Sakellaropoulos, P. Bousoulas, C. Papakonstantinopoulos, S. Kitsios, and D. Tsoukalas, 'Spatial Confinement Effects of Embedded Nanocrystals on Multibit and Synaptic Properties of Forming Free SiO₂-Based Conductive Bridge Random Access Memory', *IEEE Electron Device Letters* 41, 7, (2020)
25. D. Sakellaropoulos, P. Bousoulas, G. Nikas, C. Arvanitis, E. Bagakis, D. Tsoukalas, 'Enhancing the synaptic properties of low-power and forming-free HfO_x/TaO_y/HfO_x resistive switching devices', *Microelectronic Engineering* 229, 111358 (2020)
26. E. Aslanidis, E. Skotadis, E. Moutoulas, D. Tsoukalas 'Thin Film Protected Flexible Nanoparticle Strain Sensors: Experiments and Modeling', *Sensors*, 20(9), 2584, (2020)
27. M. Panagopoulou, D. Vernardou, E. Koudoumas, D. Tsoukalas, YS Raptis 'Tungsten doping effect on V₂O₅ thin film electrochromic performance' *Electrochimica Acta* 321, 134743
28. D. Sakellaropoulos, P. Bousoulas, D. Tsoukalas 'Impact of Pt embedded nanocrystals on the resistive switching and synaptic properties of forming free TiO_{2-x}/TiO_{2-y}-based bilayer structures' *J. Appl. Physics* 126 (4), 044501 (2019)
29. L. Patsiouras, E. Skotadis, N. Gialama, C. Drivas, S. Kennou, K. Giannakopoulos, D. Tsoukalas 'Atomic layer deposited Al₂O₃ thin films as humidity barrier coatings for nanoparticle-based strain sensors' *Nanotechnology* 29 (2018)
30. I. Michelakaki, N. Boukos, D.A Dragatogiannis, S. Stathopoulos, C. Charitidis, D. Tsoukalas 'Synthesis of hafnium nanoparticles and hafnium nanoparticle films by gas condensation and energetic deposition' *Beilstein Journal of Nanotechnology* 9, 1868 (2018)
31. L. Madianos, G. Tsekenis, E. Skotadis, L. Patsiouras, D. Tsoukalas, 'A highly sensitive impedimetric aptasensor for the selective detection of acetamiprid and atrazine based on microwires formed by platinum nanoparticles' *Biosensors and Bioelectronics* 101, (2018)
32. E Skotadis, G Tsekenis, M Chatzipetrou, L Patsiouras, L Madianos, I. Zergioti, D. Tsoukalas 'Heavy metal ion detection using DNAzyme-modified platinum nanoparticle networks' *Sensors and Actuators B: Chemical* 239, 962-969

33. E. Verrelli, I. Michelakaki, N. Boukos, G. Kyriakou, D. Tsoukalas, ‘Coalescence of Cluster Beam Generated Sub-2 nm Bare Au Nanoparticles and Analysis of Au Film Growth Parameters’ *Annalen der Physik* (2017)
34. P. Bousoulas, I. Michelakaki, E. Skotadis, M. Tsigkourakos, D. Tsoukalas, ‘Low-Power Forming Free TiO_{2-x}/HfO_{2-y}/TiO_{2-x}-Trilayer RRAM Devices Exhibiting Synaptic Property Characteristics’ *IEEE Transactions on Electron Devices* 64, (2017)
35. M. Tsigkourakos, P. Bousoulas, V. Aslanidis, E. Skotadis, D. Tsoukalas ‘Ultra-Low Power Multilevel Switching with Enhanced Uniformity in Forming Free TiO_{2-x}-Based RRAM with Embedded Pt Nanocrystals’ *Physica Status Solidi (a)* 214 (12) (2017)
36. P. Bousoulas, I. Giannopoulos, P. Asenov, I. Karageorgiou, D. Tsoukalas, ‘Investigating the origins of high multilevel resistive switching in forming free Ti/TiO_{2-x}-based memory devices through experiments and simulations’ *J. Appl. Physics* 121, (2017)
37. M. Panagopoulou, D. Vernardou, E. Koudoumas, N. Katsarakis, D. Tsoukalas, Y.S. Raptis, ‘Tunable properties of Mg-doped V₂O₅ thin films for energy applications: Li-ion batteries and electrochromics’ *Journal of Physical Chemistry C* 121, (2017)
38. I. Michelakaki, P. Bousoulas, P., S. Stathopoulos, N. Boukos, D. Tsoukalas, ‘Coexistence of bipolar and threshold resistive switching in TiO₂ based structure with embedded hafnium nanoparticles’ *Journal of Physics D: Applied Physics* 50, (2017)
39. P. Bousoulas, I. Karageorgiou, V. Aslanidis, K. Giannakopoulos, D. Tsoukalas, ‘Tuning Resistive, Capacitive, and Synaptic Properties of Forming Free TiO_{2-x}-Based RRAM Devices by Embedded Pt and Ta Nanocrystals’, *Physica Status Solidi (a)* 215 (3), 1700440
40. P. Bousoulas, P. Asenov, I. Karageorgiou, D. Sakellaropoulos, S. Stathopoulos, D. Tsoukalas, ‘Engineering amorphous-crystalline interfaces in TiO_{2-x}/TiO_{2-y}-based bilayer structures for enhanced resistive switching and synaptic properties’ *J. Appl. Physics* 120, (2016)
41. M. Panagopoulou, E. Gagaoudakis, N. Boukos, E. Aperathitis, G. Kiriakidis, D. Tsoukalas, Y.S. Raptis, ‘Thermochromic performance of Mg-doped VO₂ thin films on functional substrates for glazing applications’ *Solar Energy Materials and Solar Cells* 157, (2016)
42. E. Skotadis, K.; Voutyras, M. Chatzipetrou, et al ‘Label-free DNA biosensor based on resistance change of platinum nanoparticles assemblies’, *Biosensors & Bioelectronics* 81, 388-394 (2016)

43. P. Bousoulas, S. Stathopoulos, D. Tsialoukis, D. Tsoukalas; 'Low-Power and Highly Uniform 3-b Multilevel Switching in Forming Free TiO₂-x-Based RRAM With Embedded Pt Nanocrystals', *IEEE Electron. Dev. Lett.* 37, 874 (2016).
44. H. Guo, J. Tang, K. Qian, et al 'Vectorial strain gauge method using single flexible orthogonal polydimethylsiloxane gratings', *Nature Sc. Reports* 6 23606 (2016)
45. Z. Hai, L. Gao, Q. Zhang, et al. 'Facile synthesis of core shell structured PANI-Co₃O₄ nanocomposites with superior electrochemical performance in supercapacitors', *Appl. Surf. Science* 361, 57 (2016)
46. J. Tang, H. Guo, M. Zhao, et al. 'Highly Stretchable Electrodes on Wrinkled Polydimethylsiloxane Substrates' *Nature Sc. Reports* 5, 16527 (2015)
47. M. Panagopoulou, E. Gagaoudakis, E. Aperathitis, et al. The effect of buffer layer on the thermochromic properties of undoped radio frequency sputtered VO₂ thin films, *Thin Solid Films* 594, 310 (2015)
48. J. Tang, H. Guo, M. Chen, et al. 'Wrinkled Ag nanostructured gratings towards single molecule detection by ultrahigh surface Raman scattering enhancement', *Sensors & Actuat. B-Chem* 218, 145 (2015)
49. S. Stathopoulos, L. Tsetseris, N. Pradhan, B. Colombeau, D. Tsoukalas 'Millisecond non-melt laser annealing of phosphorus implanted germanium: Influence of nitrogen co-doping', *J. of Appl. Physics* 118, 135710 (2015)
50. P. Bousoulas, J. Giannopoulos, K. Giannakopoulos, et al. 'Memory programming of TiO₂-x films by Conductive Atomic Force Microscopy evidencing filamentary resistive switching', *Appl. Surf. Science* 332, 55 (2015)
51. P. Bousoulas, I. Michelakaki, D. Tsoukalas, 'Influence of Ti top electrode thickness on the resistive switching properties of forming free and self-rectified TiO₂ (-) (x) thin films', *Thin Solid Films* 571, 23- (2014)
52. J. Tang, H. Guo, P. An, et al. 'ZnO nanoparticles embedded in polyethylene-glycol (PEG) matrix as sensitive strain gauge elements', *J. Nanoparticle Res.* 16, 11 (2014)
53. N. Jabarullah, E. Verrelli, C. Mauldin, et al. Novel conducting polymer current limiting devices for low cost surge protection applications *J. Appl. Physics* 116, 164501(2014)
54. P. Bousoulas, I. Michelakaki, D. Tsoukalas, 'Influence of Ti top electrode thickness on the resistive switching properties of forming free and self-rectified TiO₂-x thin films', *J. Appl. Physics* 115, 034516 (2014)
55. S. Stathopoulos, A. Florakis, G. Tzortzis, D. Tsoukalas 'CO₂ Laser Annealing for USJ Formation in Silicon: Comparison of Simulation and Experiment' *IEEE Trans. Electron Dev.* 61, 696 (2014)

56. E. Verrelli, D. Tsoukalas, 'Cluster beam synthesis of metal and metal-oxide nanoparticles for emerging memories' *Solid-State Electronics* 101, 95 (2014) (*invited*)
57. I. Theodorakos, I. Zergioti, V. Vamvakas, et al., 'Picosecond and nanosecond laser annealing and simulation of amorphous silicon thin films for solar cell applications' *J. Applied Phys.* 115, 043108 (2014)
58. E. Skotadis, D. Mousadakos, K. Katsabrokou, D. Tsoukalas 'Flexible polyimide chemical sensors using platinum nanoparticles' *Sensors and Actuators B-Chemical* 189, 106 (2013)
59. E. Verrelli, D. Tsoukalas 'Investigation of the gate oxide leakage current of low temperature formed hafnium oxide films' *J. Appl. Physics*, 113, 114103 (2013)
60. E. Verrelli, D. Tsoukalas P. Normand, et al. 'Forming-free resistive switching memories based on titanium-oxide nanoparticles fabricated at room temperature' *Appl. Phys. Lett.* 102, 022909 (2013)
61. P. Broutas; H. Contopanagos, D. Tsoukalas et al. 'A RF power harvester with integrated antenna capable of operating near ground planes' *Sensors and Actuators A-Physical* 186, 284 (2012)
62. J. Tang, E. Skotadis, S. Stathopoulos, E. Roussi, V. Tsouti, D. Tsoukalas 'PHEMA functionalization of gold nanoparticles for vapor sensing: Chemi-resistance, chemi-capacitance and chemi-impedance' *Sensors and Actuators B-Chemical* 170, 129 (2012)
63. J. Tanner, D. Mousadakos, E. Skotadis, K. Giannakopoulos, D. Tsoukalas 'High strain sensitivity controlled by the surface density of Platinum nanoparticles' *Nanotechnology* 23 285501 (2012)
64. P. Broutas, H. Contopanagos, E.D. Kyriakis-Bitzaros, D. Tsoukalas, S. Chatzandroulis 'A low power RF harvester for a smart passive sensor tag with integrated antenna' *Sensors and Actuators A: Physical* 176, 34 (2012)
65. E. Verrelli, D. Tsoukalas 'Modeling of charge-trapping non-volatile-memories based on HfO₂' *Microelectronic Engineering* 90, 23 (2012)
66. M. Panagopoulou, N. Pantiskos, P. Photopoulos, J. Tang, D. Tsoukalas, Y. Raptis 'Raman enhancement of rhodamine absorbed on Ag nanoparticles self-assembled on nanowire-like arrays', *Nanoscale Research Letters* 6:629 (2011)
67. J. Tang, E. Verrelli, K. Giannakopoulos, D. Tsoukalas 'Electrostatic self-assembly of nanoparticles into ordered nanowire arrays' *J. Materials Research* 26 209 (2011)
68. J. Tang, P. Photopoulos, A. Tserepi, D. Tsoukalas 'Two dimensional nanoparticle self-assembly using plasma activated Ostwald ripening', *Nanotechnology* 22 235306 (2011)

69. E. Verrelli, D. Tsoukalas 'Optimization of hafnium oxide for use in nanoparticle memories' *Microelectronic Engineering* 88 1189 (2011)
70. V. Tsouti, C. Boutopoulos, P. Andreakou et al. 'Detection of DNA mutations using a capacitive micro-membrane array': *Biosensors & Bioelectronics* 26, 1588 (2010)
71. Tsouti V, Boutopoulos C, Goustouridis D, et al. 'A chemical sensor microarray realized by laser printing of polymers' *Sens. & Actuators B-Chem.* 150 148 (2010)
72. Skotadis E, Tang J, Tsouti V, D. Tsoukalas, 'Chemiresistive sensor fabricated by the sequential ink-jet printing deposition of a gold nanoparticle and polymer layer' *Microelectr. Engineering* 87, 2258 (2010)
73. P. Tsouroutas, D. Tsoukalas, H. Bracht 'Experiments and simulation on diffusion and activation of codoped with arsenic and phosphorous germanium' *J. Applied Phys.* 108, 024903 (2010)
74. A. Florakis, A. Papadimitriou, N Chatzipanagiotis, N. Misra, C. Grigoropoulos, D. Tsoukalas, 'Formation of silicon ultra-shallow junction by non-melt excimer laser treatment' *Solid-St.-Electr.* 54, 903 (2010)
75. E. Verrelli, G. Galanopoulos, I. Zouboulis, D. Tsoukalas 'Trapping properties of sputtered hafnium oxide films: Bulk traps vs. interface traps' *Thin Solid Films* 518, 5579 (2010)
76. A. Florakis, E. Verrelli, D. Guipertoni, D. Tsoukalas 'Non-melting annealing of silicon by CO₂ laser' *Thin Solid Films* 518, 2551 (2010)
77. D. Tsoukalas 'Metallic nanoparticles for application in non-volatile memories', *Intern. J. of Nanotechnology* 6, 35-45 (2009) (invited).
78. D. Tsoukalas 'From silicon to organic nanoparticle memory devices' *Philosophical Transactions A of the Royal Society* 1905, 4169-4179, (2009) (invited)
79. J. Tang, E. Verrelli, D. Tsoukalas, 'Assembly of charged nanoparticles using self-electrodynamic focusing', *Nanotechnology*, 20, 36 365605 (2009)
80. J. Tang, D. Tsoukalas 'Fabrication of Nanowires from Gold Nanoparticles by AC Dielectrophoresis and Ink-jet Delivery', *J. of Nano Research*, 6, 67 (2009)
81. P. Tsouroutas, D. Tsoukalas, I. Zergioti, et al 'Modeling and experiments on diffusion and activation of phosphorus in germanium', *J. Appl. Phys.* 105, 094910 (2009)
82. J. Tang, S. Kolliopoulou, D. Tsoukalas 'Fabrication of gold nanoparticle lines based on fracture induced patterning', *Microelectronic Engin.* 86, 861 (2009)

83. J. Tang, E. Verrelli, D. Tsoukalas ‘Selective deposition of charged nanoparticles by self-electric focusing effect’ *Microelectronic Engin.* 86, 898 (2009)
84. V. Tsouti, C. Boutopoulos, P. Andreakou et al. ‘Detection of the biotin-streptavidin interaction by exploiting surface stress changes on ultrathin Si membranes’ *Microelectronic Engin.* 1495-1498 (2009)
85. P. Tsouroutas, D. Tsoukalas, I. Zergioti ‘Diffusion and activation of phosphorus in germanium’, et al. *Mater. Sc. Semicond. Processing*, 372-377 (2008)
86. Florakis A, Misra N, Grigoropoulos C, et al. ‘Non-melt laser annealing of Plasma Implanted Boron for ultra-shallow junctions in Silicon’ *Mater. Sc. Engin. B* 154, 39 (2008)
87. P. Dimitrakis, P. Normand, D. Tsoukalas, C. Pearson, J.H. Ahn, M.F. Mabrook, D.A. Zeze, M.C. Petty, K. T. Kamtekar, C. Wang, M. R. Bryce, M. Green ‘Electrical behavior of memory devices based on fluorine containing organic thin films’ *J. Appl. Phys.*, 104 , 044510 (2008)
88. V. Tsouti, S. Chatzandroulis, D. Goustouridis, P. Normand, D. Tsoukalas ‘Design and fabrication of Si micromechanical capacitive array for DNA sensing’, *Microelectronic Engin.*, 85, 1359 (2008)
89. Vlachopoulou ME, Dimitrakis P, Tserepi A, et al. ‘High-density plasma silicon oxide thin films grown at room-temperature’ *Microelectronic Engin* **85, 1245 (2008)**
90. C. Pearson, J. H. Ahn, M. F. Mabrook, D. A. Zeze, M. C. Petty, K. T. Kamtekar, C. Wang, M. R. Bryce, P. Dimitrakis and D. Tsoukalas ‘Electronic memory device based on a single-layer fluorene-containing organic thin film’ *Appl. Phys. Lett.* 91, 123506 (2007)
91. E. Verrelli, I. Anastasiadis, D. Tsoukalas, M. Kokkoris, R. Vlastou, P. Dimitrakis, P. Normand ‘Proton radiation tolerance of nanocrystal memories’, *Physica E*, **38, 67 (2007)**.
92. E. Verrelli, D. Tsoukalas, K. Giannakopoulos, D. Kouvatsos, P. Normand, D. E. Ioannou ‘Nickel nanoparticle deposition at room temperature for memory applications’, *Microelectronic Eng.* 84, 1994 (2007).
93. E. Verrelli, D. Tsoukalas, M. Kokkoris, R. Vlastou, P. Dimitrakis and P. Normand ‘Proton Radiation Effects on Nanocrystal Non-Volatile Memories’, *IEEE Trans. Nucl. Sc.* 2007.
94. V. Tsouti, G. Bikakis, S. Chatzandroulis, D. Goustouridis, P. Normand and D. Tsoukalas, ‘Impact of structural parameters on the performance of silicon micromachined capacitive pressure sensors’, *Sensors and Actuators A: Physical* 137, 20-24 (2007)

95. P. Tsouroutas, D. Tsoukalas, A. Florakis, et al. 'Laser annealing for n(+)/p junction formation in germanium' *Mat Sci Semicon Proc* 9 (4-5): 644-649 (2006)
96. A. Florakis, D. Tsoukalas, I. Zergioti et al.' Laser annealing of plasma implanted boron for ultra-shallow junctions in Silicon', *Nucl Instrum Meth B* 253 (2006)
97. S. Chatzandroulis, S. Kolliopoulou, D. Goustouridis, D. Tsoukalas, 'Capacitive pressure sensors and switches fabricated using strain compensated SiGeB', *Microelectronic Eng* 83 (4-9): 1209-1211 (2006)
98. S. Kolliopoulou, P. Dimitrakis, D. Goustouridis, P. Normand, C. Pearson, M.C. Petty, H. Radamson, D. Tsoukalas, 'Metal nano-floating gate memory devices fabricated at low temperature', *Microelectronic Eng* 83 (4-9): 1563-1566 (2006)
99. D. Tsoukalas, P. Dimitrakis, S. Kolliopoulou and P. Normand, 'Recent advances in nanoparticle memories', *Materials Science and Engineering: B*, 124-125, 93-101 (2005)
100. C. Tsamis, D. Skarlatos, V. Valamontes, D. Tsoukalas, G. Benassayag, A. Claverie, W. Lerch, 'Injection of point defects during annealing of low energy As implanted silicon', *Mat Sci Eng B-Solid* 124: 261-265 (2005)
101. D. Skarlatos, C. Tsamis, M. Perego, M. Fanciulli and D. Tsoukalas, 'Interstitial injection during oxidation of very low energy nitrogen-implanted silicon' *Materials Science and Engineering: B*, 124-125, 314-318, (2005)
102. A. Kanjilal, J.L. Hansen, P. Gaiduk, A. Nylasted Larsen, P. Dimitrakis, P. Normand, D. Tsoukalas, N. Cherchashin, A. Claverie, 'Size and aerial density distributions of Ge nanocrystals in a SiO₂ layer produced by molecular beam epitaxy and rapid thermal processing', *Appl Phys A-Mater* 81 (2): 363-366 (2005)
103. S. Kolliopoulou, P. Dimitrakis, D. Goustouridis, S. Chatzandroulis, P. Normand, D. Tsoukalas, H. Radamson, 'A Si/SiGe MOSFET utilizing low-temperature wafer bonding,' *Microelectronic Eng* 78-79: 244-247 (2005)
104. S. Chatzandroulis, E. Tegou, D. Goustouridis, S. Polymenakos, D. Tsoukalas, 'Capacitive-type chemical sensors using thin silicon/polymer bimorph membranes', *Sensor Actuat B-Chem* 103 (1-2): 392-396 (2004)
105. P. Dimitrakis, E. Kapetanakis, D. Tsoukalas et al. 'Silicon nanocrystal memory devices obtained by ultra-low-energy ion-beam synthesis', *Solid State Electron* 48 (9): 1511-1517 (2004)
106. S. Kolliopoulou, P. Dimitrakis, P. Normand, H.L Zhang, N. Cant, S.D. Evans, C. Pearson, S. Paul, A. Molloy, M.C. Petty, D. Tsoukalas, 'Integration of organic insulator and self-assembled gold nanoparticles on Si MOSFET for novel non-volatile memory cells', *Microelectronic Eng* 73-4: 725-729 (2004)

107. P. Normand, P. Dimitrakis, E. Kapetanakis, D. Skarlatos, K. Beltsios, D. Tsoukalas et al., 'Processing issues in silicon nanocrystal manufacturing by ultra-low-energy ion-beam-synthesis for non-volatile memory applications', *Microelectronic Eng* 73-4: 730-735 (2004)
108. S. Chatzandroulis, E. Tegou, D. Goustouridis, S. Polymenakos, D. Tsoukalas, 'Fabrication of chemical sensors based on Si/polymer bimorphs', *Microelectronic Eng* 73-4: 847-851 (2004)
109. D. Skarlatos, E. Kapetanakis, P. Normand, C. Tsamis, S. Ferrari, M. Perego, M. Fanciulli, D. Tsoukalas, 'Oxidation of nitrogen-implanted silicon: Comparison of nitrogen distribution and electrical properties of oxides formed by very low and medium energy N²(+) implantation', *J Appl Phys* 96 (1): 300-309 (2004)
110. D. Skarlatos, M. Perego, C. Tsamis, M. Ferrari, M. Fanciulli, D. Tsoukalas, 'Nitrogen distribution during oxidation of low and medium energy nitrogen-implanted silicon', *Nucl Instrum Meth B* 216: 75-79 (2004)
111. P. Normand, E. Kapetanakis, P. Dimitrakis, D. Skarlatos, K. Beltsios, D. Tsoukalas et al. 'Nanocrystals manufacturing by ultra-low-energy ion-beam-synthesis for non-volatile memory applications', *Nucl Instrum Meth B* 216: 228-238 (2004)
112. D. Goustouridis, K. Minoglou, S. Kolliopoulou, S. Chatzandroulis, P. Morfouli, P. Normand, D. Tsoukalas, 'Low temperature wafer bonding for thin silicon film transfer', *Sensor Actuat A-Phys* 110 (1-3): 401-406 (2004)
113. S. Kolliopoulou, P. Dimitrakis, P. Normand, H.L. Zhang, N. Cant, S.D. Evans, C. Pearson, S. Paul, A. Molloy, M.C. Petty, D. Tsoukalas, 'Hybrid silicon-organic nanoparticle memory device', *J Appl Phys* 94 (8): 5234-5239 (2003)
114. P. Normand, E. Kapetanakis, P. Dimitrakis, D. Tsoukalas et al., 'Effect of annealing environment on the memory properties of thin oxides with embedded Si nanocrystals obtained by low-energy ion-beam synthesis', *Appl Phys Lett* 83 (1): 168-170 (2003)
115. E. Kapetanakis, D. Skarlatos, C. Tsamis, P. Normand, D. Tsoukalas, 'Influence of implantation energy on the electrical properties of ultrathin gate oxides grown on nitrogen implanted Si substrates' *Appl Phys Lett* 82 (26): 4764-4766 (2003)
116. S. Paul, C. Pearson, A. Molloy, M.A. Cousins, M. Green, S. Kolliopoulou, P. Dimitrakis, P. Normand, D. Tsoukalas, M.C. Petty, 'Langmuir-Blodgett film deposition of metallic nanoparticles and their application to electronic memory structures' *Nano Lett* 3 (4): 533-536 (2003)
117. D. Skarlatos, C. Tsamis, D. Tsoukalas, 'Oxidation of nitrogen-implanted silicon: Energy dependence of oxide growth and defect characterization of the silicon substrate', *J Appl Phys* 93 (3): 1832-1838 (2003)

118. P. Dimitrakis, E. Kapetanakis, P. Normand, D. Skarlatos, D. Tsoukalas et al. 'MOS memory structures by very-low-energy-implanted Si in thin SiO₂', *Mat Sci Eng B-Solid* 101 (1-3): 14-18 (2003)
119. M. Carrada, N. Cherkashin, C. Bonafos, G. Benassayag, D. Chassaing, P. Normand, D. Tsoukalas, V. Soncini, A. Claverie, 'Effect of ion energy and dose on the positioning of 2D-arrays of Si nanocrystals ion beam synthesised in thin SiO₂ layers', *Mat Sci Eng-Solid* 101 (1-3): 204-207 (2003)
120. D. Mathiot, J.P. Schunck, M. Perego, M. Fanciulli, C. Tsamis, P. Normand, D. Tsoukalas, 'Silicon self-diffusivity measurement in thermal SiO₂ by Si-30/Si-28 isotopic exchange', *J Appl Phys* 94 (3): 2136-2138 (2003)
121. P. Normand, E. Kapetanakis, P. Dimitrakis, D. Skarlatos, D. Tsoukalas et al., 'Effects of annealing conditions on charge storage of Si nanocrystal memory devices obtained by low-energy ion beam synthesis', *Microelectronic Eng* 67-8: 629-634 (2003)
122. M. Carrada, C. Bonafos, G.B. Assayag, D. Chassaing, P. Normand, D. Tsoukalas, V. Soncini, A. Claverie, 'Effect of ion energy and dose on the positioning of 2D-arrays of Si nanocrystals ion beam synthesized in thin SiO₂ layers', *Physica E* 17 (1-4): 513-515 (2003)
123. A. Kanjilal, J.L. Hansen, P. Gaiduk, A. Nylansted Larsen, N. Cherkashin, A. Claverie, D. Skarlatos, E. Kapetanakis, P. Normand, D. Tsoukalas, 'Structural and electrical properties of silicon dioxide layers with embedded germanium nanocrystals grown by molecular beam epitaxy', *Appl Phys Lett* 82 (8): 1212-1214 (2003)
124. G.B. Assayag, C. Bonafos, M. Carrada, A. Claverie, P. Normand, D. Tsoukalas, 'Transmission electron microscopy measurements of the injection distances in nanocrystal-based memories', *Appl Phys Lett* 82 (2): 200-202 (2003)
125. S. Polymenakos, V.S. Stergiou, A.G. Kontos, C. Tsamis, Y. Raptis, D. Tsoukalas 'Influence of Ge implantation on the mechanical properties of polycrystalline silicon microstructures', *J. Micromech. And Microeng.* 12 (4): 450 (2002)
126. E. Kapetanakis, P. Normand, D. Tsoukalas and K. Beltsios 'Influence of implantation dose on the charge storage characteristics of MOS memory devices with low energy Si implanted gate oxides' *Microelectronic Engineering*, Volumes 61-62, 505-510 (2002)
127. P. Normand, K. Beltsios, A. Tserepi, C. Aidinis, D. Tsoukalas, C. Cardinaud, 'A new masking method for protecting silicon surfaces during anisotropic silicon wet etching', *Microelectron Eng* 61-2: 895-900 JUL 2002
128. K. Beltsios, P. Normand, E. Kapetanakis, D. Tsoukalas, A. Travlos, 'Evolution and control of the structure of a SiO₂/semiconductor nanoelectronics material', *Microelectronic Eng* 61-2: 631-635 (2002)

129. E. Kapetanakis, P. Normand, D. Tsoukalas, K. Beltsios, 'Room-temperature single-electron charging phenomena in large-area nanocrystal memory obtained by low-energy ion beam synthesis', *Appl. Phys. Lett.* 80 (15): 2794-2796 (2002)
130. S. Chatzandroulis, A. Tserepi, D. Goustouridis, P. Normand and D. Tsoukalas 'Fabrication of single crystal Si cantilevers using a dry release process and application in a capacitive-type humidity sensor', *Microelectronic Engineering*, 61-62, 955-961 (2002)
131. P Normand , K. Beltsios K, A. Tserepi K, Aidinis , D. Tsoukalas, C. Cardinaud 'A masking approach for anisotropic silicon wet etching' *Electrochem. And Solid State Lett.* 4: G73 (2001)
132. P. Normand, E. Kapetanakis, D. Tsoukalas, A. Tserepi, E. Tsoi, K. Beltsios, K. Aidinis, S. Zhang and J. van den Berg 'Silicon-nanocrystal-based multiple-tunnel junction devices obtained by a combination of V-groove and ion beam synthesis techniques', *Microelectronic Engineering*, 57-58, 1003, (2001)
133. D. Tsoukalas, D. Skarlatos and J. Stoemenos 'Investigation of the influence of a dislocation loop layer on interstitial kinetics during surface oxidation of silicon', *Nuclear Instruments and Methods B*, 178, 80, (2001)
134. P. Normand, E. Kapetanakis, D. Tsoukalas et al., 'MOS memory devices based on silicon nanocrystal arrays fabricated by very low energy ion implantation', *Mat Sc. Eng C-Bio S* 15 (1-2): 145-147, (2001)
135. D. Tsoukalas, C. Tsamis, P. Normand 'Diffusivity measurements of silicon in silicon dioxide layers using isotopically pure material', *Journal of Applied Physics*, 89, 7809 (2001)
136. S. Chatzandroulis, D. Tsoukalas 'Capacitance to frequency converter suitable for sensor applications using telemetry' in *Analog Integrated circuits and Signal Processing*, 27, 31 (2001)
137. P. Normand, K. Beltsios, E. Kapatanakis, D. Tsoukalas, T. Travlos, J. Van den Berg, S. Zhang, J. Gautier, L. Palun 'Formation of two dimensional arrays of semiconductor nanocrystals or semiconductor-rich nanolayers by very low energy Si or Ge ion implantation in silicon oxide films' in *Nucl. Instr. and Methods B* 178, 74 (2001)
138. F. Cristiano, B. Colombeau, B. de Mauduit, M. Omri, A. Claverie, F. Giles, D. Skarlatos, D. Tsoukalas 'Influence of annealing ambients on relative stabilities of dilocation loops in silicon' in *Nucl. Instrum. and Methods B*, 178, 84 (2001)
139. E. Kapetanakis, P. Normand, D. Tsoukalas et al. 'Charge storage and interface states effects in Si-nanocrystal memory obtained using low-energy implantation and annealing', *Applied Physics Letters* 77, 3450 (2000)

140. D. Tsoukalas, D. Skarlatos, J. Stoemenos 'Investigation of the interaction between interstitials and dislocation loops using the wafer bonding technique', *J. Appl. Phys.* 87, 8380-84 (2000)
141. D. Skarlatos, D. Tsoukalas, L. F. Giles and A. Claverie 'Point defect injection during nitrous oxidation of silicon', *J. Appl. Phys.* 87, 1103-1109 (2000)
142. S. Chatzandroulis, D. Tsoukalas, P. Neukomm 'A miniature pressure system with a capacitive sensor and a passive telemetry link for use in implantable applications' *IEEE J. of Microelectromechanical Systems* 9, 18-23 (2000)
143. D. Skarlatos, M. Omri, A. Claverie, D. Tsoukalas 'Estimation of the number of interstitial atoms injected in silicon during thin oxide formation', *J. of The Electrochemical Soc.* 146, 2276-2283 (1999)
144. D. Goustouridis, D. Tsoukalas, P. Normand, A. Kontos, Y. Raptis, E. Anastassakis 'Parameters influencing the flatness and stability of capacitive pressure sensors fabricated with wafer bonding' *Sensors & Actuators* 76 403-408, (1999)
145. L. F. Giles, M. Omri, B. de Mauduit, A. Claverie, D. Skarlatos, D. Tsoukalas 'Coarsening of End-of-Range defects in ion implanted silicon annealed in neutral and oxidizing ambients', *Nucl. Instr. and Method. in Phys. Research B148*, 273-278 (1999)
146. C. Tsamis and D. Tsoukalas 'Model for the recombination of silicon interstitials at non oxidizing interfaces', *J. Appl. Phys.* 84, 6650 (1998)
147. D. Goustouridis, P. Normand and D. Tsoukalas 'Ultraminiature capacitive pressure sensing elements obtained with fusion bonding' *Sensors & Actuators A* 68, 269 (1998)
148. P. Dimitrakis, S. Hatzandroulis, D. Tsoukalas, J. Stoimenos and G. Papaioannou 'Electrical characterization of silicon wafer bonding structures' *Solid-State Electronics* 42, 201 (1998)
149. D. Tsoukalas, P. Normand, C. Aidinis, E. Kapetanakis and P. Argitis 'Fabrication of Si nanodevices by optical lithography and anisotropic etching' *Microelectronic Engineering* 41/42, 523 (1998)
150. P. Normand, D. Tsoukalas, E. Kapetanakis, J. A. Van Den Berg, G. A. Armour and J. Stoemenos' Formation of 2-D arrays of Silicon nanocrystals in thin SiO₂ films by very-low energy Si ion implantation' *Electrochemical and Solid-State Letters*, 1, 88 (1998)
151. D. Goustouridis, P. Normand and D. Tsoukalas 'Miniaturization of Si diaphragms obtained by wafer bonding' *Microelectronic Engineering* 41/42, 437 (1998)

152. P. Normand, D. Tsoukalas, C. Aidinis, A. Tserepi, D. Kouvatsos and E. Kapetanakis 'Fabrication of Si nanowires using anisotropic dry and wet etching', *Microelectronic Engineering* 41/42, 551 (1998)
153. S. Chatzandroulis, D. Goustouridis, P. Normand and D. Tsoukalas 'A solid-state pressure sensing microsystem for biomedical applications', *Sensors & Actuators A* 62, 551, (1997)
154. P. Normand, D. Tsoukalas, E. Kapetanakis, J. A. Van Den Berg, G. A. Armour and J. Stoemenos 'Silicon nanocrystal formation in thin oxides by very-low-energy silicon implantation', *Microelectronic Engineering* 36, 79 (1997)
155. D. Tsoukalas, C. Tsamis, D. Kouvatsos, P. Revva and E. Tsoi 'Reduction of the Reverse Short Channel Effect in thick SOI MOSFETs', *IEEE Electron Device Lett.* 18, 90 (1997)
156. C. Tsamis, D. Kouvatsos and D. Tsoukalas 'Influence of N₂O silicon oxidation on point defect injection kinetics in the high temperature regime', *Appl. Phys. Lett.* 69, 2725 (1996)
157. D. Tsoukalas, D. Kouvatsos 'Silicon interstitial trapping in polycrystalline silicon films', *Appl. Phys. Lett.* 68, 1549 (1996)
158. D. Kouvatsos, D. Tsoukalas, E. Sarcona, M. Hatalis and J. Stoemenos 'A single crystal silicon thin film transistors fabricated at low process temperature on glass substrate', *Electronics Letters* 32, 775 (1996)
159. D. Goustouridis, S. Chatzandroulis, P. Normand and D. Tsoukalas 'A miniature self-aligned pressure element', *Journal of Micromechanics and Microengineering* 6, 33 (1996)
160. D. Tsoukalas, P. Dimitrakis, G. Papaioannou and J. Stoemenos 'Electrical and Structural characterization of wafer bonded non-annealed SIMOX', *Microelectronic Engineering* 28, 471 (1995)
161. C. Tsamis, D. Tsoukalas and P. Normand 'Decrease of the lateral distribution of interstitials in silicon-on-insulator', *Microelectronic Engineering* 28, 463 (1995)
162. D. Tsoukalas and C. Tsamis 'Investigation of the silicon interstitials distribution in silicon and silicon-on-insulator', *Appl. Phys. Lett.* 66, 971 (1995)
163. D. Tsoukalas, C. Tsamis and J. Stoemenos 'Investigation of silicon interstitial reactions with insulating films', *Appl. Phys. Lett.* 63, 3169 (1993)
164. C. Tsamis, D. Tsoukalas and N. Guillemot 'Silicon interstitial reactions with thermally grown silicon dioxide', *Microelec. Engineering* 22, 363 (1993)
165. C. Tsamis, D. Tsoukalas and J. Stoemenos 'Comparison of the growth and shrinkage of Oxidation Stacking Faults in silicon and silicon-on-insulator', *J. Appl. Phys.* 73, 3246 (1993)

166. J. Boussey-Said, N. Guillemot, J. Stoemenos and D. Tsoukalas 'Oxidation Stacking faults in silicon-on-insulator structures obtained with the wafer-bonding', *J. Electrochem. Soc.* 140, 544 (1993)
167. N. Glezos, J. Raptis, D. Tsoukalas and M. Hatzakis 'Application of a new analytical technique of electron distribution calculations to the profile simulation of a high sensitivity negative e-beam resist', *J. Vac. Sci. and Technol.* B10(6), 2606 (1992)
168. N. Guillemot, D. Tsoukalas, C. Tsamis, J. Margail and J. Stoemenos 'Suppression mechanisms for oxidation stacking faults in Silicon-On-Insulator', *J. Appl. Phys.* 71, 1713 (1992)
169. N. Guillemot, D. Tsoukalas, C. Tsamis, J. Margail, A.M.Papon and J.Stoemenos 'Suppression of oxidation stacking faults in silicon separation by oxygen', *Mater. Sci. Engin.* B12, 47 (1992)
170. D. Tsoukalas, C. Tsamis, N. Guillemot, J. Stoemenos and J. Margail 'Study of the growth kinetics of oxidation-induced stacking faults in separation by implanted oxygen structures using a new chemical etching process', *Mater. Sci. Engin.* B12, 209 (1992)
171. C. Tsamis, D. Tsoukalas, N. Guillemot, J. Stoemenos and J. Margail 'Characterization of oxidation-induced stacking faults in SOI structures formed by a new chemical etching process', *Semicond. Sci. Technol.* 7, A193 (1992)
172. C. Tsamis, D. Tsoukalas, N. Guillemot, J. Stoemenos and J. Margail 'A new chemical etching for the delineation of Oxidation Stacking faults in Silicon-On-Insulator', *J. Electrochem. Soc.* 38, 2752 (1991)
173. D. Tsoukalas 'Transient boron diffusion in silicon under oxidizing ambient and extrinsic conditions. Influence of point defect recombination', *J. Appl. Phys.* 70, 7309 (1991)
174. D. Tsoukalas 'Range of high energy phosphorus and medium energy boron ions implanted in polymers', *Solid-St. Electronics* 33, 639 (1990)
175. P. Normand, D. Tsoukalas, N. Guillemot and J. Stoemenos 'Boron diffusion in Silicon-On-Insulator formed by Oxygen implantation', *J. Electrochem. Soc.* 137, 2306 (1990)
176. P. Normand, D. Tsoukalas, N. Guillemot and P. Chenevier 'A pile-up phenomenon during arsenic diffusion in Silicon-On-Insulator formed by Oxygen implantation', *J. Appl. Phys.* 66, 3585 (1989)
177. D. Tsoukalas and P. Chenevier 'A model for the oxidation-enhanced diffusion of boron in extrinsic silicon', *J. Appl. Phys.* 66, 1858 (1989)

178. N. Guillemot, P. Normand, D. Tsoukalas and P. Chenevier 'Diffusion de l'arsenic dans les structures silicium-sur-isolant obtenues par implantation d'oxygene', *Revue de Phys. Appl.* 23, 1369 (1988)
179. D. Tsoukalas and P. Chenevier 'Boron diffusion in silicon in inert and oxidizing ambient and extrinsic conditions', *Phys. St. Sol. (a)*, 100, 461 (1987)
180. L. Bouro and D. Tsoukalas 'Determination of doping and mobility profiles by automatic electrical measurements and anodic stripping', *J. Phys.E : Scientific. Instruments* 20, 541 (1987)
181. D. Tsoukalas and P. Chenevier 'Boron diffusion in silicon by a vacancy mechanism', *Phys. St. Sol. (a)*, 92, 495 (1985)

Articles in Encyclopaedias and Books

1. E. Kapetanakis, P. Normand, K. Beltsios, D. Tsoukalas, *Nanocrystal memories* in: H. S. Nalwa (Ed.), *Encyclopaedia of Nanoscience and Nanotechnology*, American Scientific Publishers, USA, Vol.6, pp. 321-340, 2003
2. D. Tsoukalas, S. Chatzandroulis, D. Goustouridis 'Capacitive Microsensors', In *Encyclopaedia of Medical Devices and Instrumentation*, ed. By J. Webster, Wiley & Sons, 2006
3. P. Dimitrakis, P. Normand, D. Tsoukalas 'Silicon Nanocrystal Memories' in *Silicon Nanophotonics: Basic Principles, Present Status, and Perspectives* edited by L. Khriachtchev, publ. by Pan Stanford Publishing, 2008 and 2016
4. P. Bousoulas, D. Tsoukalas 'Understanding the switching properties of metal oxide bilayer films through simulation and modeling' in *Advanced Engineering Materials and Modeling* ed. A. Tiwari, publ. by Wiley-Scrivener 2016
5. E. Verrelli, D. Tsoukalas 'Nanoparticles-Based Flash-Like Nonvolatile Memories: Cluster Beam Synthesis of Metallic Nanoparticles and Challenges for the Overlying Control Oxide Layer' in *Charge-Trapping Non-Volatile Memories* by Springer 2016
6. S. Stathopoulos, D. Tsoukalas, 'Laser-matter interactions', in *Laser Annealing Processes in Semiconductor Technology*, (2021), 49-78

Proceedings Editor

- *SISPAD 2001 Proceedings*, Springer Verlag, together with C. Tsamis
- '*Materials and Processes for non-volatile memories*' MRS Fall Meeting 2004, Boston, together with A. Claverie, J. Slaughter, T-J King

- ‘Materials and Processes for non-volatile memories’ , MRS Spring Meeting 2007, San Francisco, together with J. Slaughter, Y. Fujisaki, T-K Li
- *ESSDERC Proceedings*, Athens 2009 together with A. Dimoulas
- *ESSCIRC Proceedings*, Athens 2009, together with Y. Papananos
- *Micro & Nano Conference*, Athens 2015, Special Issue of Microelectronic Engineering 2016

Patents

- [1] United States Patent, US6704185, Publication date: 09-03-2004, Inventors: S. Chatzandroulis, D. Goustouridis, D. Tsoukalas, P. Normand, Capacitive pressure-responsive devices and their fabrication, after PCT (No. PCT/IB01/00208, publication WO 01/63645, 30/8/2001).
- [2] European Patent Application, No: EP 01600006, Publication date: 18-09-2002 “Method for masking silicon during anisotropic wet etching”, Inventors: P. Normand, K. Beltsios, A. Tserepi, K. Aidinis, and D. Tsoukalas.
- [3] Greek Patent στον OBI (no 1004286) “Χημικά Επιλεκτικός Αισθητήρας Τύπου Χωρητικότητας Και Μέθοδος Κατασκευής Του”, Δ. Τσουκαλάς, Σ. Χατζανδρούλης, Δ. Γουστουρίδης, P. Normand, A. Τσερέπη, η οποία κατοχυρώνει διαδικασία κατασκευής αισθητήρων υγρασίας από μονοκρυσταλλικό πυρίτιο (chemical capacitive sensor for humidity measurement).

Presentations in international Conferences with full Proceedings

1. European Solid-State Device Research Conference ‘Emulating artificial mechanoreceptor functionalities from SiO₂-based memristor and PDMS stretchable sensor for artificial skin applications’ P. Bousoulas, Ch. Papakonstantinopoulos, D. Tsoukalas, Grenoble, France, Sept. 2021 <https://doi.org/10.1109/ESSDERC53440.2021.9631826>
2. EUROMAT Symposium on ‘Processes and Materials for Nanoelectronics’ ‘Tuning of resistive switching and synaptic properties by embedding Pt nanocrystals in TiO_x bilayer devices, Stockholm, Sweden, Sept. 2019
3. Micro and Nano Engineering Conference ‘The effect of cracked alumina substrate on high sensitive Pt nanoparticle strain sensor’, E. Aslanidis, L. Patsiouras, E. Skotadis, K. Giannakopoulos, D. Tsoukalas, Rhodes, Sept. 2019
4. P Bousoulas, I Giannopoulos, P Asenov, I Karageorgiou, D Tsoukalas, ‘Experiments and simulation of multilevel resistive switching in forming free Ti/TiO_{2-x} RRAM devices’, Joint International EUROSIOI Workshop and International Conference on Ultimate Integration on Silicon (EUROSIOI-ULIS) 2017 <https://doi.org/10.1109/ULIS.2017.7962574>

5. P Bousoulas, P Asenov, D Tsoukalas, ‘Physical modelling of the SET/RESET characteristics and analog properties of TiO_x/HfO_{2-x}/TiO_x-based RRAM devices’, Simulation of Semiconductor Processes and Devices (SISPAD), 2016
<https://doi.org/10.1109/SISPAD.2016.7605194>
6. P. Bousoulas, D. Sakellaropoulos, J. Giannopoulos, D. Tsoukalas, ‘Improving the resistive switching uniformity of forming-free TiO_{2-x} based devices by embedded Pt nanocrystals’, ESSDERC 2015
10.1109/ESSDERC.2015.7324767
7. D. Tsoukalas, E. Verrelli, P. Bousoulas, N. Boukos, High density Au nanoclusters for highly efficient non-volatile memories, MRS-Fall Meeting 2014
8. P. Bousoulas, I. Michelakaki, J. Giannopoulos, K. Giannakopoulos, and D. Tsoukalas, “Material and Device Parameters Influencing Multi-Level Resistive Switching of Room Temperature Grown Titanium Oxide Layers”, MRS-Fall Meeting 2014
<https://doi.org/10.1557/opl.2015.84>
9. E. Skotadis, D. Mousadakos, J. Tanner, D. Tsoukalas, ‘Flexible platinum nanoparticle strain sensors’ (ESSDERC 2013)
<https://doi.org/10.1109/ESSDERC.2013.6818891>
10. D. Tsoukalas and E. Verrelli, "Inorganic Nanoparticles for either Charge Storage or Memristance Modulation", Advances in Science and Technology, Vol. 77, pp. 196-204, 2013
<https://doi.org/10.4028/www.scientific.net/AST.77.196>
11. E. Skotadis, D. Mousadakos, K. Katsabrokou, S. Stathopoulos, D. Tsoukalas, Platinum nanoparticle chemical sensors on polyimide substrates, 2012, Procedia engineering 47 (Eurosenors 2012 conference).
12. E. Verrelli, D. Tsoukalas Forming free resistive switching in titanium oxide nanoparticles, ESSDERC 2012)
13. J.L. Tanner, E. Skotadis, S. Stathopoulos, V. Tsouti, D. Tsoukalas, Chemi-resistive sensors based on platinum nanoparticle arrays, 2011, Procedia engineering 25 (Eurosenors 2011 conference).
14. Jun Tang, E. Verrelli, D. Tsoukalas, “*Assembly of charged nanoparticles by self-electrodynamic focusing*”, Proceedings of the 39th European Solid-State Device Research Conference, 456 (2009).
15. A. Florakis et al. “Formation of Silicon Ultra Shallow Junction by non melt excimer laser treatment” Proceedings of the 39th European Solid-State Device Research Conference, 284 (2009).
16. V. Tsouti, S. Chatzandroulis, D. Goustouridis, P. Broutas, P. Normand, C. Boutopoulos, I. Zergioti, D. Tsoukalas “*A chemical sensor array based on*

Si/polymer bimorphs” Eurosensors XXII, Dresden, Germany, 7-10 September, 2008

17. V. Tsouti, D. Goustouridis, S. Chatzandroulis, P. Normand, P. Andreakou, M. Ioannou, D. Kafetzopoulos, C. Boutopoulos, I. Zergioti, D. Tsoukalas, J. Hue, R. Rousier, “A capacitive biosensor based on ultrathin Si membranes” IEEE Sensors 2008, Lecce, Italy, 26-29 October, 2008
18. E. Verrelli, D. Tsoukalas et al. ‘Deposition of uniform size metallic nanoparticles for use in non-volatile memories’ *Materials Research Society Proc. Vol 997, 2007*
19. S. Kolliopoulou, D. Tsoukalas, P. Dimitrakis, P. Normand, S. Paul, C. Pearson, A. Molloy, M. C. Petty ‘Field effect devices with metal nanoparticles integrated by Langmuir–Blodgett technique for non-volatile memory applications’ *J. Phys.: Conf. Ser.* 10 (2005) 57-60
20. G. Kaltsas, D. Goustouridis, A. G. Nassiopoulou, D. Tsoukalas ‘Combination of integrated thermal flow and capacitive pressure sensors for high sensitivity flow measurements in both laminar and turbulent regions’ *J. Phys.: Conf. Ser.* 10 (2005) 277-280
21. S. Kolliopoulou, D. Tsoukalas et al. ‘Gold Langmuir-Blodgett deposited nanoparticles for non-volatile memories’ *Materials Research Society Proc. Vol 830, 2004*
22. S. Kolliopoulou, D. Tsoukalas et al. ‘A multi-stack insulator silicon organic memory device with gold nanoparticles’ *European Solid State Device Research Conference (ESSDERC’2003), Editions Frontieres*
23. C. Tsamis, D. Skarlatos, I. Raptis, D. Tsoukalas, P. Calvo, B. Colombeau, F. Cristiano, A. Claverie ‘Annealing behavior of locally confined dislocation loops under inert and oxidizing ambients’, *Materials Research Society Proc. Vol 717, 2002*
24. D. Tsoukalas, C. Tsamis, P. Normand ‘Use of isotopically pure silicon to estimate silicon diffusivity in silicon dioxide’ *Materials Research Society Proc. Vol. 669, 2001.*
25. C. Tsamis, D. Tsoukalas, A. Tserepi, E. Tsoi ‘The influence of silicon interstitial clusters on the Reverse Short Channel Effect’, *European Solid State Device Research Conference (ESSDERC’2000), Editions Frontieres*
26. E. Kapetanakis, P. Normand, D. Tsoukalas, G. Kamoulakos, D. Kouvatsos, J. Stoemenos, S. Zhang, J. van den Berg, D. G. Armour ‘MOS memory using silicon nanocrystals formed by very-low energy ion implantation’ *European Solid State Device Research Conference (ESSDERC’2000), Editions Frontieres*

27. E. Kapetanakis, P. Normand, D. Tsoukalas et al 'Structure and memory effects of low energy Ge-implanted thin silicon dioxide films' *European Solid State Device Research Conference (ESSDERC'99)*, Editions Frontieres, pp. 432-435
28. D. Skarlatos, L. F. Giles, C. Tsamis, A. Claverie, D. Tsoukalas 'Estimation of the number of injected interstitials during nitrous oxidation of silicon' *Material Res, Soc. Symposium on Front-End Silicon Processing Physics and Technology*, San Francisco 1999
29. S. Chatzandroulis, D. Tsoukalas, P. Neukomm 'A passive telemetry system with a capacitive silicon sensor suitable for blood pressure measurements' *Transducers'99*, 1038-1041, Sendai, Japan, 1999
30. S. Chatzandroulis, D. Tsoukalas, P. Neukomm 'A pressure measuring system using passive telemetry and a silicon capacitive sensor', *Euroensors XIII*, 471, The Hague, The Netherlands 1999
31. S. Chatzandroulis, D. Tsoukalas 'Capacitance to frequency converter suitable for sensor applications using telemetry', *IEEE Intern. Conf. On Electronics, Circuits and Systems*, Pafos Cyprus, Sept. 5-8 1999
32. D. Skarlatos, M. Omri, C. Tsamis, A. Claverie and D. Tsoukalas 'Point defect injection in silicon during thin oxide formation', in *Semiconductor Silicon 1998*, ed. by H. R. Huff et al., *The Electrochemical Soc.*, 98-1, 914 (1998)
33. D. Skarlatos, C. Tsamis, M. Omri, A. Claverie and D. Tsoukalas 'Point defect parameter extraction through their reaction with dislocation loops', *Simulation of Semiconductor Processes and Devices* ed. by K. De Meyer et al., *Springer*, 356 (1998)
34. D. Goustouridis, D. Tsoukalas, P. Normand 'Parameters influencing the flatness and stability of capacitive pressure sensors fabricated with wafer bonding' *Euroensors 1998*, Inst. of Physics
35. D. Tsoukalas and C. Tsamis 'The influence of process physics on the MOS device performance. The case of the reverse short channel effect' *International Semiconductor Conference*, Sinaia, Romania, Oct. 1997, p.117
36. C. Tsamis and D. Tsoukalas, 'Point Defect generation during Si oxidation and oxynitridation", NATO Advanced Research Workshop on *Fundamental Aspects of Ultrathin Dielectrics on Si-based devices: Towards an Atomic-Scale Understanding*, NATO ASI Series, *Kluwer Acad. Publ.* p.359 (1998)
37. C. Tsamis, D. N. Kouvatsos and D. Tsoukalas, 'Point Defect injection kinetics by N₂O oxidation of silicon", *Defects and Diffusion in Silicon Processing*, *MRS Soc.*
38. F. Gaiseanu, C. Postolache, D. Dascalu, J. Esteve, D. Tsoukalas, A. Badoiu, E. Vasile 'Material characterization of the capacitive pressure sensors fabricated

- by surface micromachining technology', *Eurosensors XII, Inst. of Physics*, pp. 4346 (1997)
39. P. Dimitrakis, S. Hatzandroulis, D. Tsoukalas, J. Stoemenos and G. Papaioannou 'On the electrical properties of Si wafer bonded structures. Evidence of anomalous pile-up of phosphorus' *4th Intern. Symposium on semiconductor wafer bonding, The Electrochem. Soc.*
 40. D. Tsoukalas, D. Kouvatsos, E. Tsoi, P. Revva and C. Tsamis 'Influence of silicon thickness on the Reverse Short Channel Effect of SOI MOSFETs', *European Solid State Device Research Conference (ESSDERC'96), Editions Frontieres*, pp.83-86 (1996)
 41. D. Tsoukalas, C. Tsamis, D. Kouvatsos and D. Scarlatos 'Estimation of point defect properties by using SOI structures and devices', *4th International Conference on Process Physics in Semiconductor Technology, The Electrochemical Society*, Vol. 96-4, pp. 348-358 (1996)
 42. C. Tsamis and D. Tsoukalas 'Modelling of silicon interstitial surface recombination velocity at non-oxidizing interfaces', *Simulation of Semiconductor Devices and Processes, Springer Verlag*, Vol. 6, pp. 452-454 (1995)
 43. D. Tsoukalas, N. Guillemot, P. Normand, K. Reeson and J. Stoemenos 'Oxidation induced stacking faults in silicon on insulator', *20th Intern. Conf. on the Physics in Semiconductors, World Scientific*, pp. 340-343 (1990)
 44. D. Tsoukalas, P. Normand and N. Guillemot 'Influence of defects on the impurity diffusion in SIMOX structures', *18th Intern.Conf. on Defects in Semiconductors, Materials Science Forum* Vol. 38-41, pp. 201-207 (1989)
 45. D. Tsoukalas, P. Normand and N. Guillemot 'Diffusion of arsenic in SIMOX structures', *ESSDERC'88, Solid State Devices, Elsevier Sci.Publ.*, pp. 619-621 (1988)
 46. D. Tsoukalas and P. Chenevier 'Boron diffusion in heavily n-doped silicon', *Proceedings of the Symposium on Defects in silicon' The Electrochemical Soc.*, Vol. 83-9, pp. 347-356 (1983)
- **In addition, 35 presentations** at international Conferences (Micro-Nano Engineering (MNE), Insulating Films on Semiconductors (INFOS), E-MRS Symposia) without full proceedings that usually are later published in journals and **20 presentations** at national Conferences

CITATIONS

Total number of citations found from Web of Science is over 3450 (h-index 31), from Scopus is over 4100 (h-index 32) and from Google scholar over 5400 (h-index 36).